

Application/Control No.	Applicant(s)/Patent under Reexamination
09/944,375	MOTTIER ET AL.
Examiner	Art Unit
Hanh Nguyen	2662

	SEAR	CHED	
Class	Subclass	Date	Examiner
370	335	9/8/05	HW
	340		
	208		
	210		
	342		
375	227		
	340		
	224		
	147		

INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
	1					

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East	7/5/05	HN
,		